

Notice of References Cited	Application/Control No. 10/536,553		Applicant(s)/Patent Under Reexamination VAN DEIJZEN, WILHELMUS P	
	Examiner CHIKAODILI E. ANYIKIRE		Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,611,206 B2	08-2003	Eshelman et al.	340/573.1
*	B	US-2004/0158869 A1	08-2004	Safran et al.	725/105
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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